

**Search Notes**

Application/Control No.

10/827,243

Examiner

Yonel Beaulieu

Applicant(s)/Patent under  
Reexamination

IDE ET AL.

Art Unit

3661

**SEARCHED**

Class	Subclass	Date	Examiner
701	29	2/2/2007	YB
	36		
	45-47		
280	728.1		
	734-735		
307	9.1		
	10.1		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR